



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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Application of :
Takashi OGAWA : Group Art Unit - 2881
Appln. No. 10/590,127 : Examiner: B. J. Purinton
Filed: AUGUST 18, 2006 :
For: SEMICONDUCTOR INSPECTION :
METHOD AND SYSTEM THERE- :
FOR : Docket No. S005-5850 (PCT)

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Mail Stop Amendment
COMMISSIONER FOR PATENTS
P.O. Box 1450
Alexandria, VA 22313-1450

RESPONSE

S I R:

In response to the Office Action mailed September 11, 2008, applicant amends his application as follows:

ADDITIONAL FEE:

Enclosed herewith is a check in the sum of \$324.00 to cover the cost of one additional independent claim and two additional claims in excess of those previously paid for. Should the check prove deficient for any reason or should other fees be required, authorization is hereby given to charge any such deficiency or fees to our Deposit Account No. 01-0268.

01/22/2009 ENGUYEN2 0000037 10590127
02 FP 1614 220-00-00
03 FC 1615

MAILING CERTIFICATE ON PAGE 23

01/22/2009 ENGUYEN2 0000037 10590127

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